

<b>Notice of References Cited</b>		Application/Control No. 10/734,591	Applicant(s)/Patent Under Reexamination INOUE, JIRO	
		Examiner Gary Estremsky	Art Unit 3676	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,106,135	04-1992	Menke et al.	292/216
	B	US-6,126,212	10-2000	Fujihara, Yoshihiko	292/216
	C	US-6,554,329	04-2003	DeBlock et al.	292/216
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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**NON-PATENT DOCUMENTS**

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